Search Notes			

Application/Contro		plicant(s)/Patent under examination	
09/600,925	TAI	NAKA, IZURU	
Examiner	Art	: Unit	
Benjamin C. Lee	263	32	

SEARCHED					
Subclass	Date	Examiner			
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		<u> </u>			
	Subclass	Subclass Date			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
340	309.16	8/17/05	m	
	309.8			
	304.9			
368	10 223 251 262	8/17/05	pm	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (see text search history printout)	8/15/2005	pi		
	8/16/2005	m		
	8/17/2005	pv		
considered: US 6763238 US 6385412	8/17/05	pr		